

Product Summary

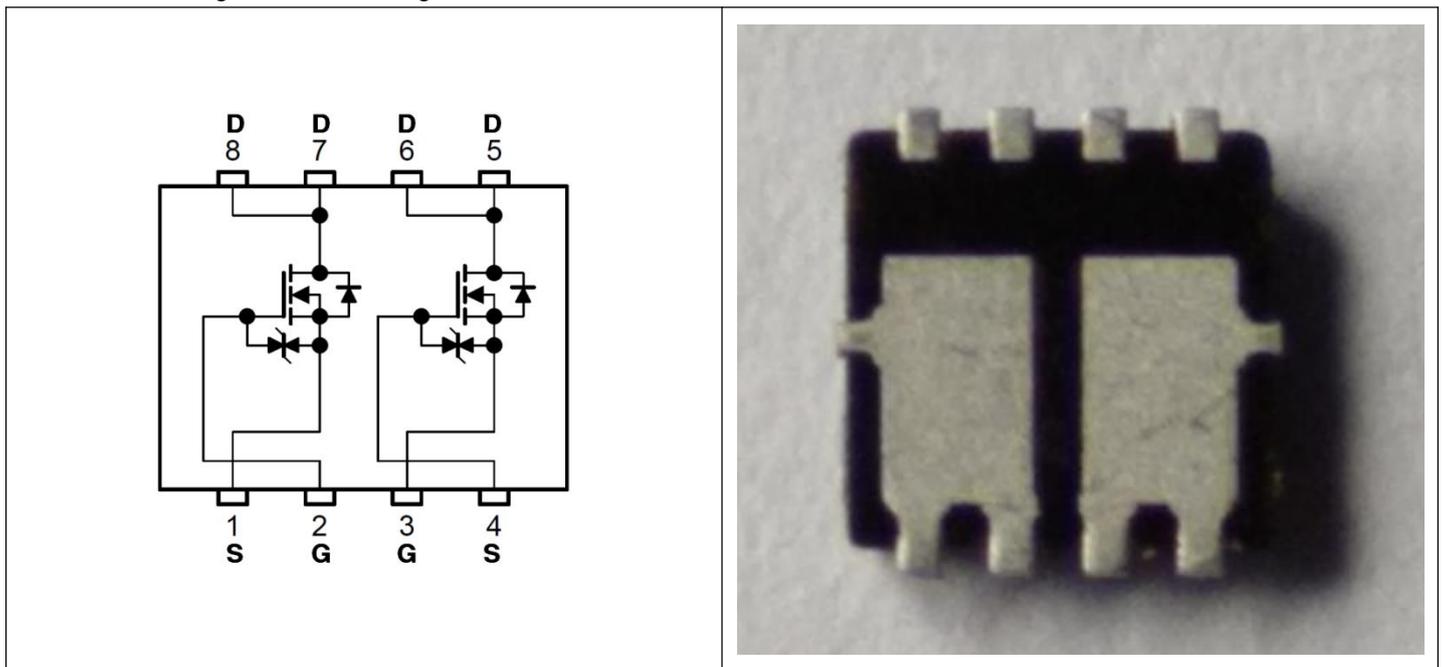
BV_{DSS}	$R_{DS(ON)}$	I_D
20V	22m	6.5A
-20V	37m	-4A

Description

These N+P Dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Mechanical Data

- Case: DFN 3.3×3.3-8
- Circuit Configuration: See diagram below



Applications

- Notebook
- Networking
- Load Switch
- Hand-held Instruments

Features

- Fast switching
- Green Device Available
- Suit for 1.8V Gate Drive Applications
- High Power and current handing capability

N-CH Electrical Characteristics ($T_J=25\text{ }^\circ\text{C}$, unless otherwise)

(1) ABSOLUTE MAXIMUM RATINGS($T_A=25\text{ }^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 8	V
Drain Current-Continuous@ Current-Pulsed (Note 1)	I_D	6.5	A
	I_{DM}	30	A
Maximum Power Dissipation	P_D	1.4	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	$^\circ\text{C}$

(2) THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	90	$^\circ\text{C/W}$
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(3) ELECTRICAL CHARACTERISTICS ($T_A=25\text{ }^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 4.5V, V_{DS}=0V$			± 1	μA
		$V_{GS}=\pm 8V, V_{DS}=0V$			± 10	μA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.4	0.6	1	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=6.5A$		18	22	$m\Omega$
		$V_{GS}=2.5V, I_D=5.5A$		24	30	$m\Omega$
		$V_{GS}=1.8V, I_D=5A$		40	55	$m\Omega$
Forward Transconductance	g_{FS}	$V_{DS}=5V, I_D=6.5A$		7		S
DYNAMIC CHARACTERISTICS (Note 4)						
Input Capacitance	C_{iss}	$V_{DS}=10V, V_{GS}=0V,$ $F=1.0MHz$		1160		PF
Output Capacitance	C_{oss}			200		PF
Reverse Transfer Capacitance	C_{rss}			140		PF
SWITCHING CHARACTERISTICS (Note 4)						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=10V, I_D=1A$ $V_{GS}=5V, R_{GEN}=3\Omega$		6.5		nS
Turn-on Rise Time	t_r			13		nS
Turn-Off Delay Time	$t_{d(off)}$			50		nS
Turn-Off Fall Time	t_f			30		nS
Total Gate Charge	Q_g	$V_{DS}=10V, I_D=6.5A,$ $V_{GS}=4.5V$		10		nC
Gate-Source Charge	Q_{gs}			2.3		nC
Gate-Drain Charge	Q_{gd}			3		nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage (Note 3)	V_{SD}	$V_{GS}=0V, I_S=1A$		0.76	1	V

NOTES:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, $t \leq 10$ sec.
- ③ Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
- ④ Guaranteed by design, not subject to production testing

(4) TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

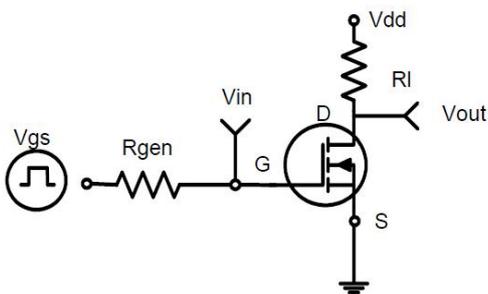


Figure 1: Switching Test Circuit

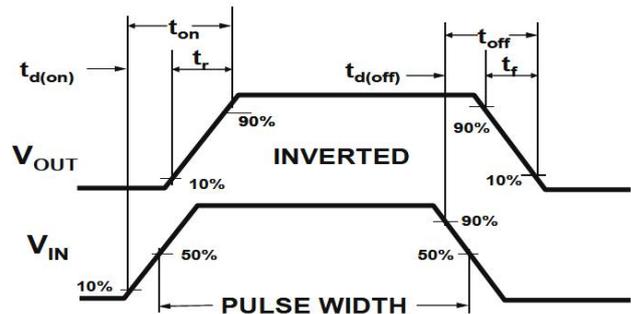


Figure 2: Switching Waveforms

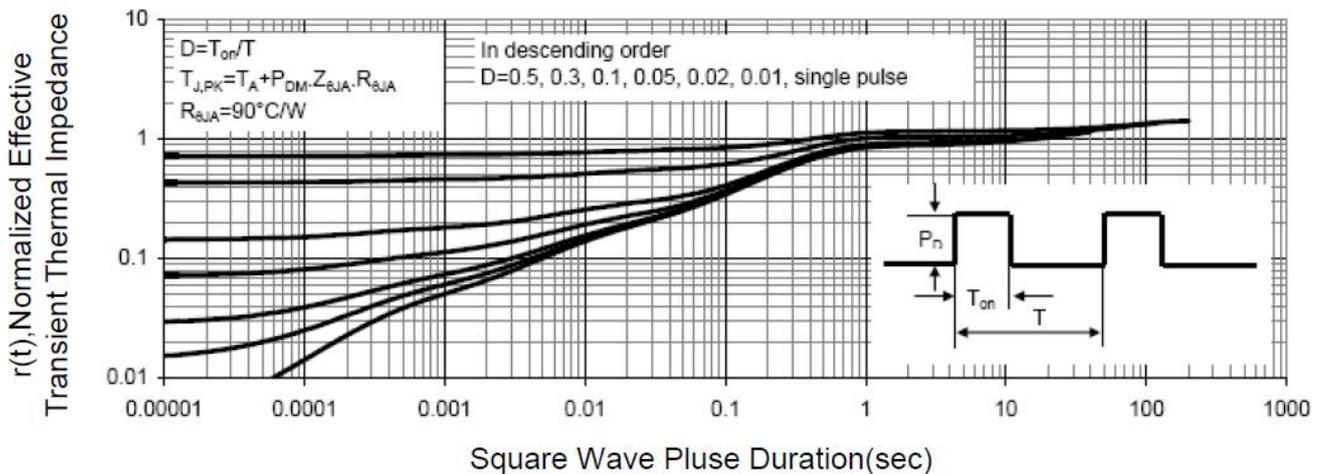


Figure 3 Normalized Maximum Transient Thermal Impedance

P-CH Electrical Characteristics (T_J=25 °C, unless otherwise)

(1) Absolute max Rating: @TA=25°C unless otherwise specified

Symbol	Parameter	Max.	Units
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V	-4 ①	A
I _D @ TC = 70°C	Continuous Drain Current, V _{GS} @ 10V	-2.4 ①	
I _{DM}	Pulsed Drain Current ②	-30	
P _D @TC = 25°C	Power Dissipation ③	1.4	W
V _{DS}	Drain-Source Voltage	-20	V
V _{GS}	Gate-to-Source Voltage	±8	V
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C

(2) Thermal Resistance

Symbol	Characterizes	Typ.	Max.	Units
R _{θJA}	Junction-to-ambient (t ≤ 10s) ④	—	90	°C/W

(3) Electrical Characterizes @TA=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	-20	—	—	V	V _{GS} = 0V, I _D = -250μA
R _{DS(on)}	Static Drain-to-Source on-resistance	—	37	43	mΩ	V _{GS} = -4.5V, I _D = -4A
		—	45	54		V _{GS} = -2.5V, I _D = -4A
V _{GS(th)}	Gate threshold voltage	-0.3	—	-1.0	V	V _{DS} = V _{GS} , I _D = -250μA
		—	-0.44	—		T _J = 125°C
I _{DSS}	Drain-to-Source leakage current	—	—	-1	μA	V _{DS} = -16V, V _{GS} = 0V
		—	—	-50		T _J = 125°C
I _{GSS}	Gate-to-Source forward leakage	—	—	10	μA	V _{GS} = 8V
		—	—	-10		V _{GS} = -8V
Q _g	Total gate charge	—	10	—	nC	I _D = -4A, V _{DS} = -10V, V _{GS} = -4.5V
Q _{gs}	Gate-to-Source charge	—	0.77	—		
Q _{gd}	Gate-to-Drain("Miller") charge	—	3.5	—		
t _{d(on)}	Turn-on delay time	—	10	—	ns	V _{GS} = -4.5V, V _{DS} = -10V, R _{GEN} = 3Ω,
t _r	Rise time	—	8.6	—		
t _{d(off)}	Turn-Off delay time	—	29	—		
t _f	Fall time	—	13	—		
C _{iss}	Input capacitance	—	939	—	pF	V _{GS} = 0V, V _{DS} = -10V,
C _{oss}	Output capacitance	—	130	—		
C _{rss}	Reverse transfer capacitance	—	111	—		

(4) Source-Drain Ratings and Characteristics

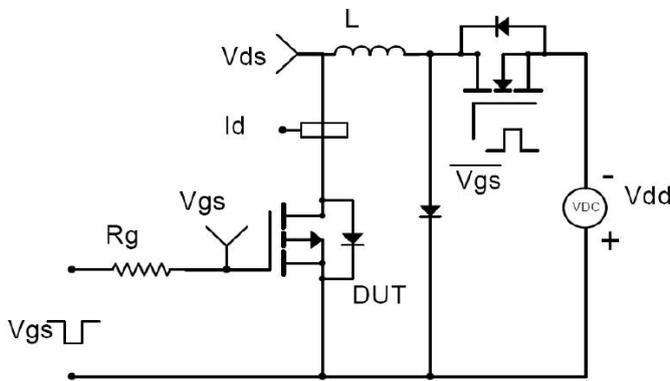
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-4 ①	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode)	—	—	-30	A	
V_{SD}	Diode Forward Voltage	—	-0.76	-1.0	V	$I_S=1A, V_{GS}=0V$
t_{rr}	Reverse Recovery Time	—	8.7	—	ns	$T_J = 25^\circ C, I_F = -4A,$
Q_{rr}	Reverse Recovery Charge	—	2.3	—	nC	$di/dt = 100A/\mu s$

Notes:

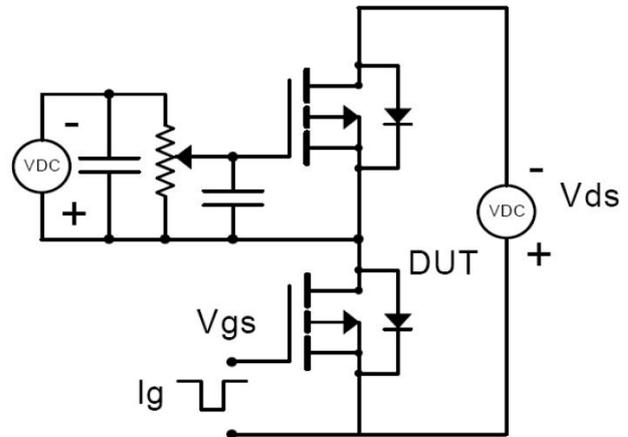
- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of $R\theta_{JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$

(5) Test circuits and Waveforms

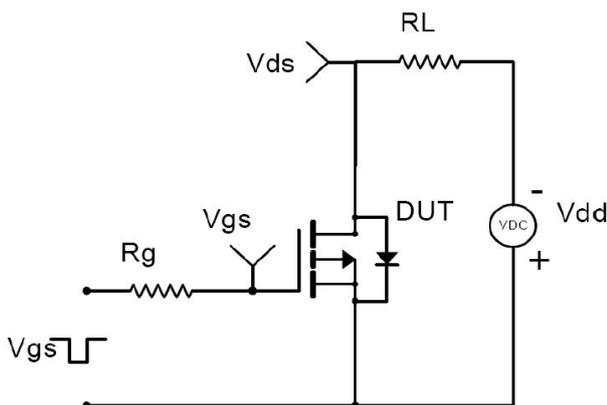
EAS test circuit:



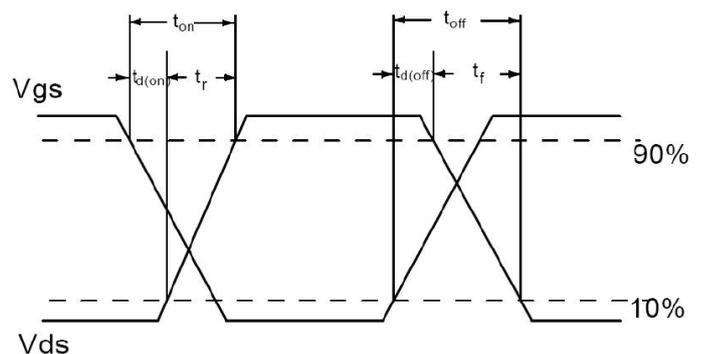
Gate charge test circuit:



Switching time test circuit:



Switch Waveforms:



(6) Typical electrical and thermal characteristics

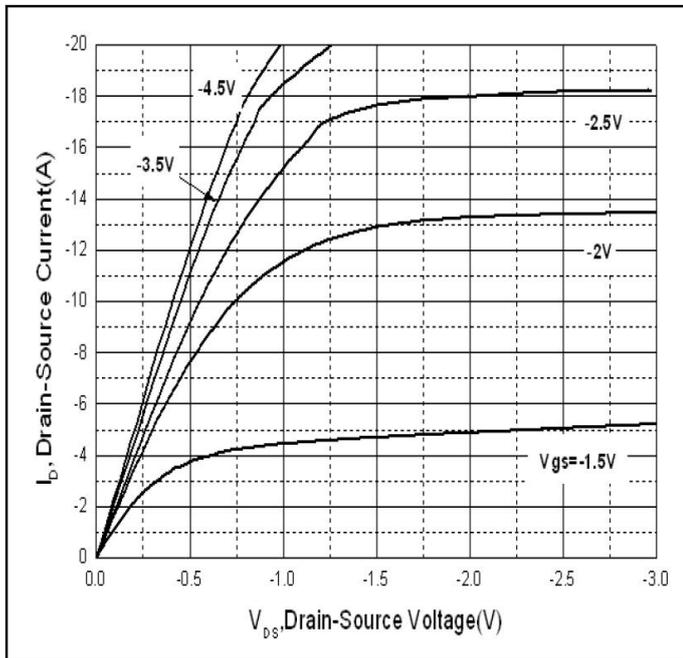


Figure 1: Typical Output Characteristics

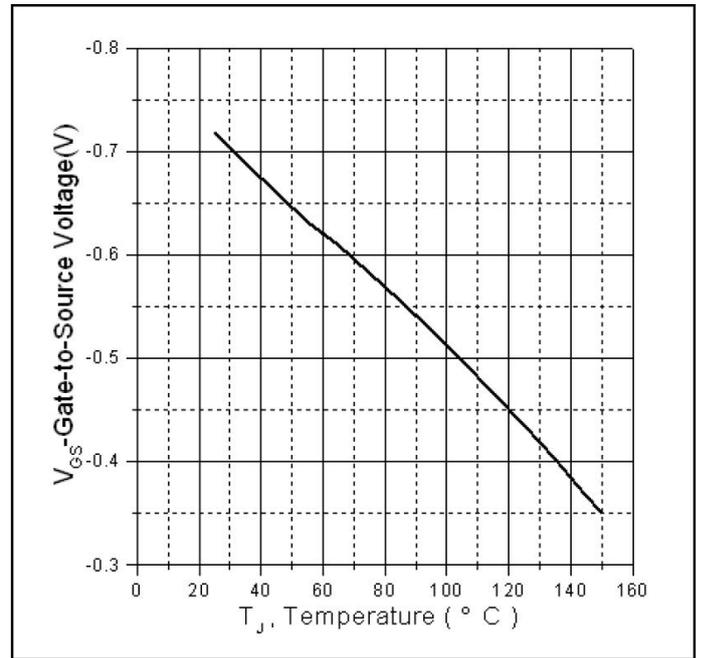


Figure 2. Gate to source cut-off voltage

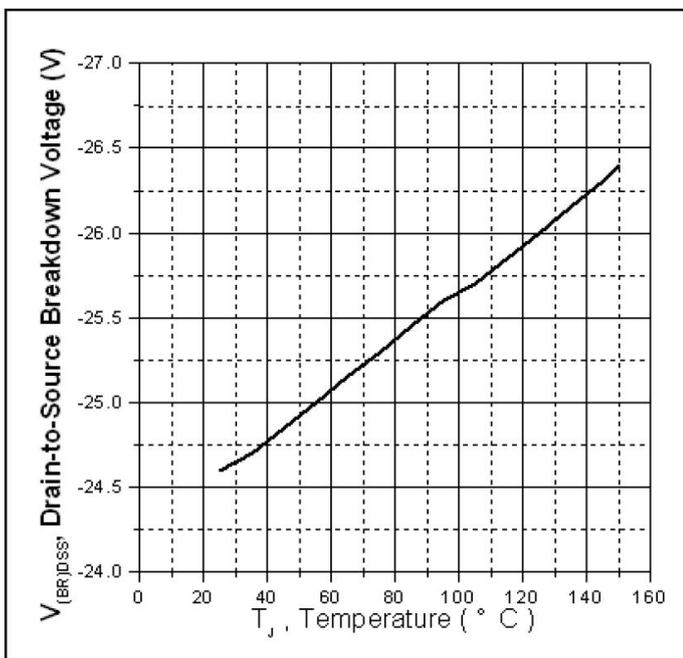


Figure 3: Drain-to-Source Breakdown Voltage Vs. Case Temperature

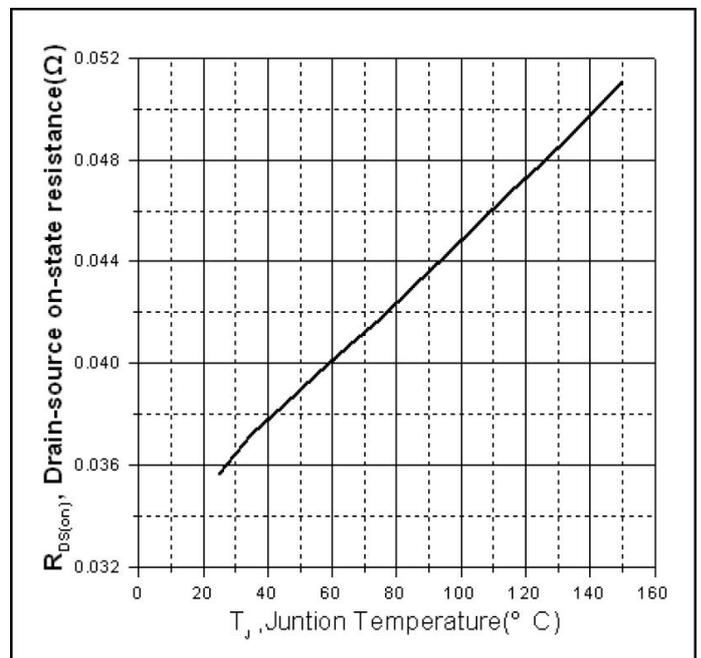


Figure 4: Normalized On-Resistance Vs. Case Temperature

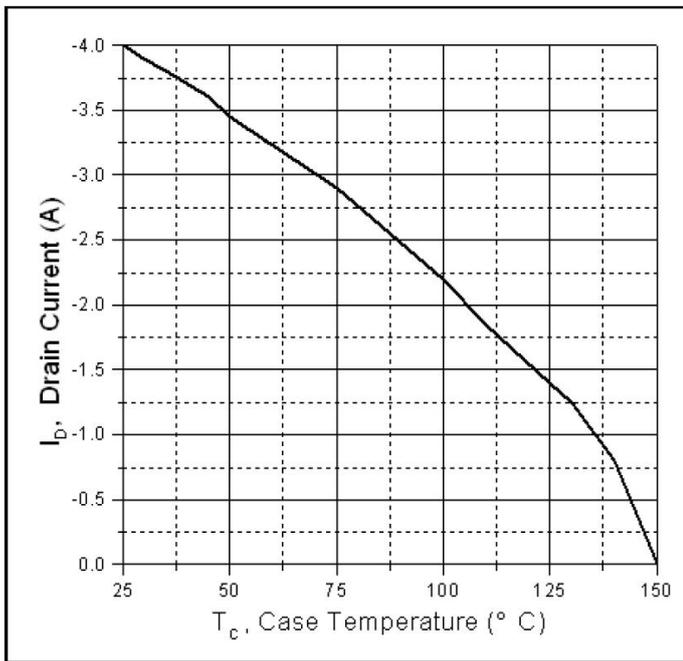


Figure 5: Maximum Drain Current Vs. Case Temperature

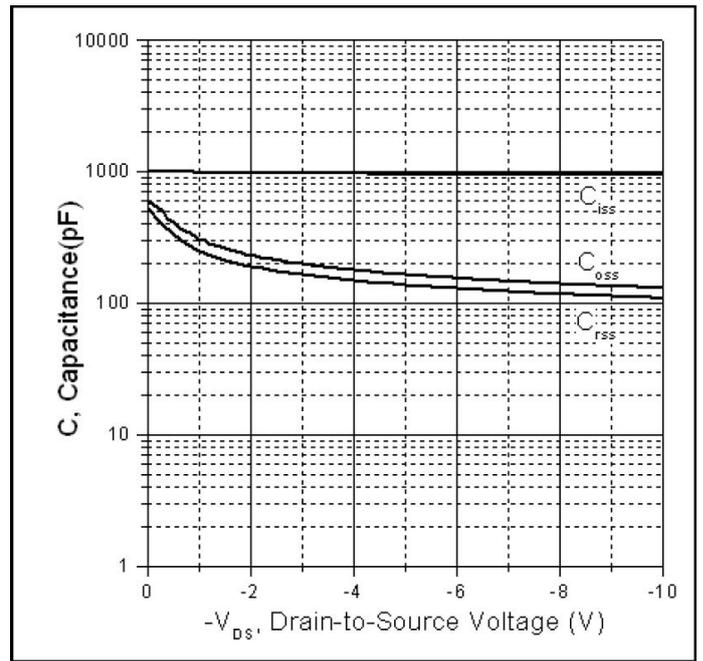


Figure 6: Typical Capacitance Vs. Drain-to-Source Voltage

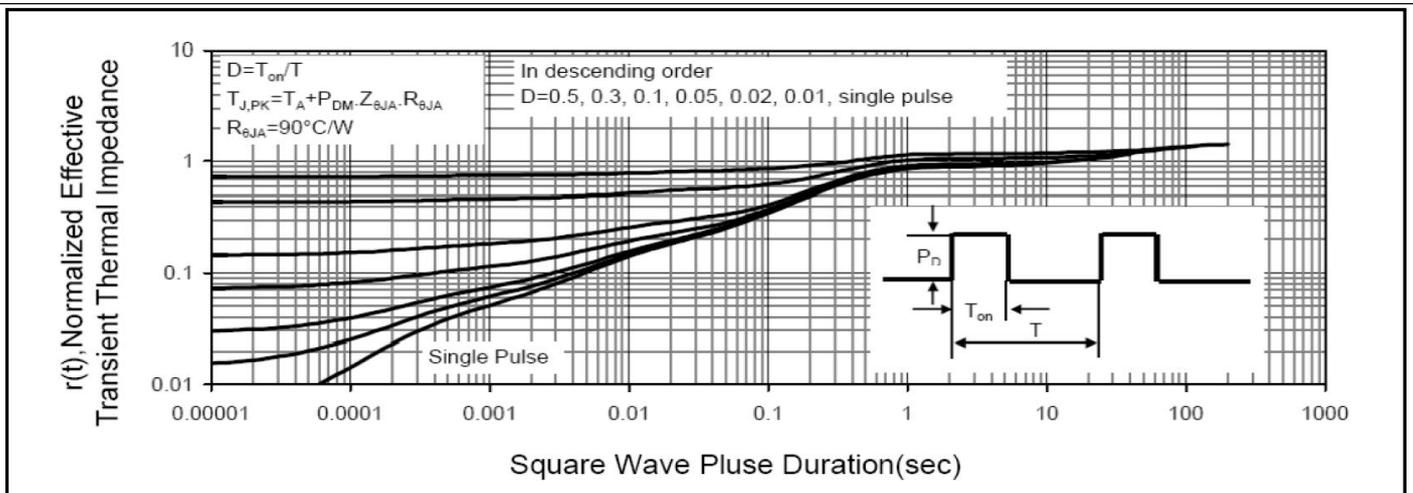
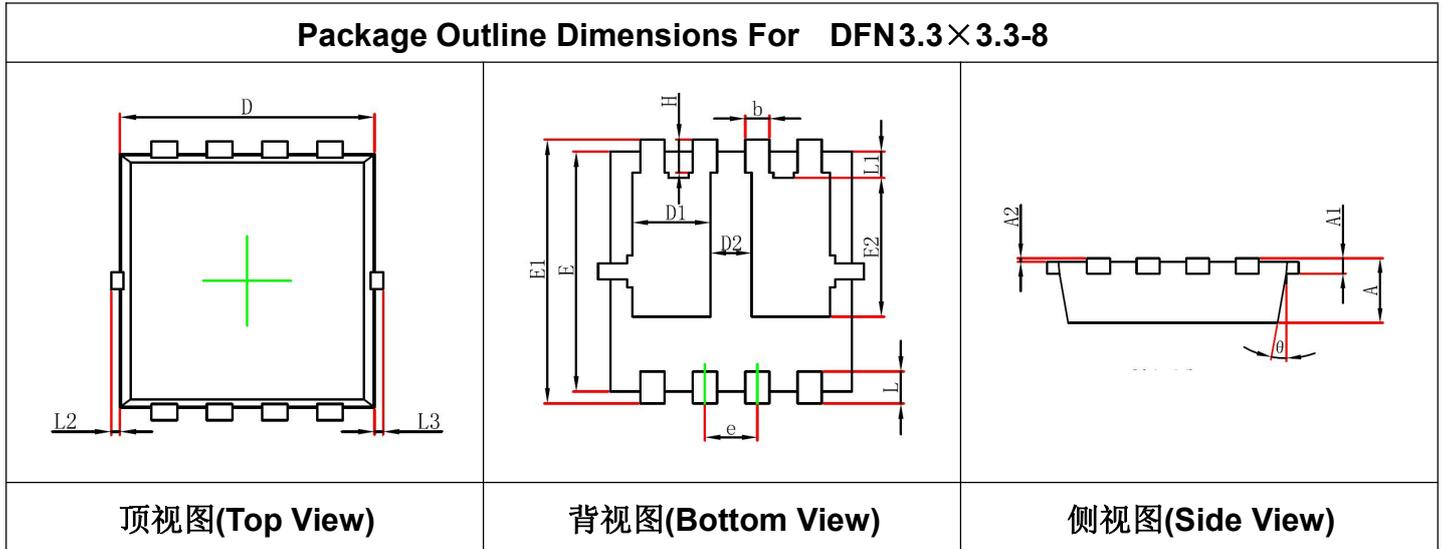


Figure 7. Maximum Effective Transient Thermal Impedance Junction-to-Case

Package Outline Dimensions

Package Outline Dimensions For DFN3.3×3.3-8



顶视图(Top View)

背视图(Bottom View)

侧视图(Side View)

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.650	0.850	0.026	0.033
A1	0.152 REF.		0.006 REF.	
A2	0~0.05		0~0.002	
D	2.900	3.100	0.114	0.122
D1	0.935	1.135	0.037	0.045
D2	0.280	0.480	0.011	0.019
E	2.900	3.100	0.114	0.122
E1	3.150	3.450	0.124	0.136
E2	1.535	1.935	0.060	0.076
b	0.200	0.400	0.008	0.016
e	0.550	0.750	0.022	0.030
L	0.300	0.500	0.012	0.020
L1	0.180	0.480	0.007	0.019
L2	0~0.100		0~0.004	
L3	0~0.100		0~0.004	
H	0.315	0.515	0.012	0.020
θ	9°	13°	9°	13°